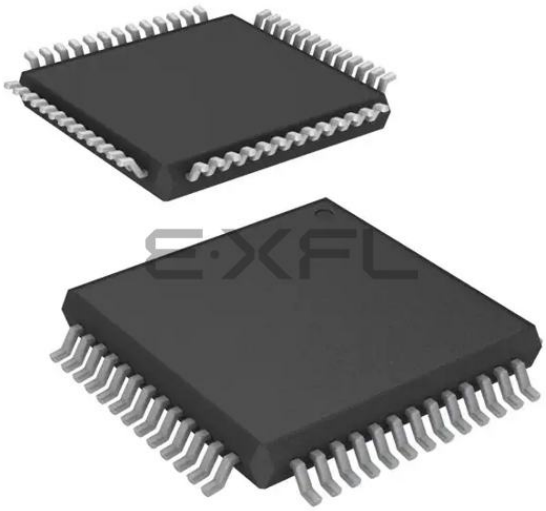

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Details	
Product Status	Active
Core Processor	R8C
Core Size	16-Bit
Speed	20MHz
Connectivity	I²C, LINbus, SIO, SSU, UART/USART
Peripherals	POR, Voltage Detect, WDT
Number of I/O	41
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	2.2V ~ 5.5V
Data Converters	A/D 12x10b
Oscillator Type	Internal
Operating Temperature	-20°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	52-LQFP
Supplier Device Package	52-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f21256snfp-v2

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1.4 Product Information

Table 1.3 lists the Product Information for R8C/24 Group and Table 1.4 lists the Product Information for R8C/25 Group.

Table 1.3 Product Information for R8C/24 Group **Current of Feb. 2008**

Type No.	ROM Capacity	RAM Capacity	Package Type	Remarks
R5F21244SNFP	16 Kbytes	1 Kbyte	PLQP0052JA-A	N version Blank product
R5F21245SNFP	24 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21246SNFP	32 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21247SNFP	48 Kbytes	2.5 Kbytes	PLQP0052JA-A	
R5F21248SNFP	64 Kbytes	3 Kbytes	PLQP0052JA-A	
R5F21244SNLG	16 Kbytes	1 Kbyte	PTLG0064JA-A	
R5F21246SNLG	32 Kbytes	2 Kbytes	PTLG0064JA-A	
R5F21244SDFP	16 Kbytes	1 Kbyte	PLQP0052JA-A	D version Blank product
R5F21245SDFP	24 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21246SDFP	32 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21247SDFP	48 Kbytes	2.5 Kbytes	PLQP0052JA-A	
R5F21248SDFP	64 Kbytes	3 Kbytes	PLQP0052JA-A	
R5F21244SNXXXFP	16 Kbytes	1 Kbyte	PLQP0052JA-A	N version Factory programming product(1)
R5F21245SNXXXFP	24 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21246SNXXXFP	32 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21247SNXXXFP	48 Kbytes	2.5 Kbytes	PLQP0052JA-A	
R5F21248SNXXXFP	64 Kbytes	3 Kbytes	PLQP0052JA-A	
R5F21244SNXXXLG	16 Kbytes	1 Kbyte	PTLG0064JA-A	
R5F21246SNXXXLG	32 Kbytes	2 Kbytes	PTLG0064JA-A	
R5F21244SDXXXFP	16 Kbytes	1 Kbyte	PLQP0052JA-A	D version Factory programming product(1)
R5F21245SDXXXFP	24 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21246SDXXXFP	32 Kbytes	2 Kbytes	PLQP0052JA-A	
R5F21247SDXXXFP	48 Kbytes	2.5 Kbytes	PLQP0052JA-A	
R5F21248SDXXXFP	64 Kbytes	3 Kbytes	PLQP0052JA-A	

NOTE:
1. The user ROM is programmed before shipment.

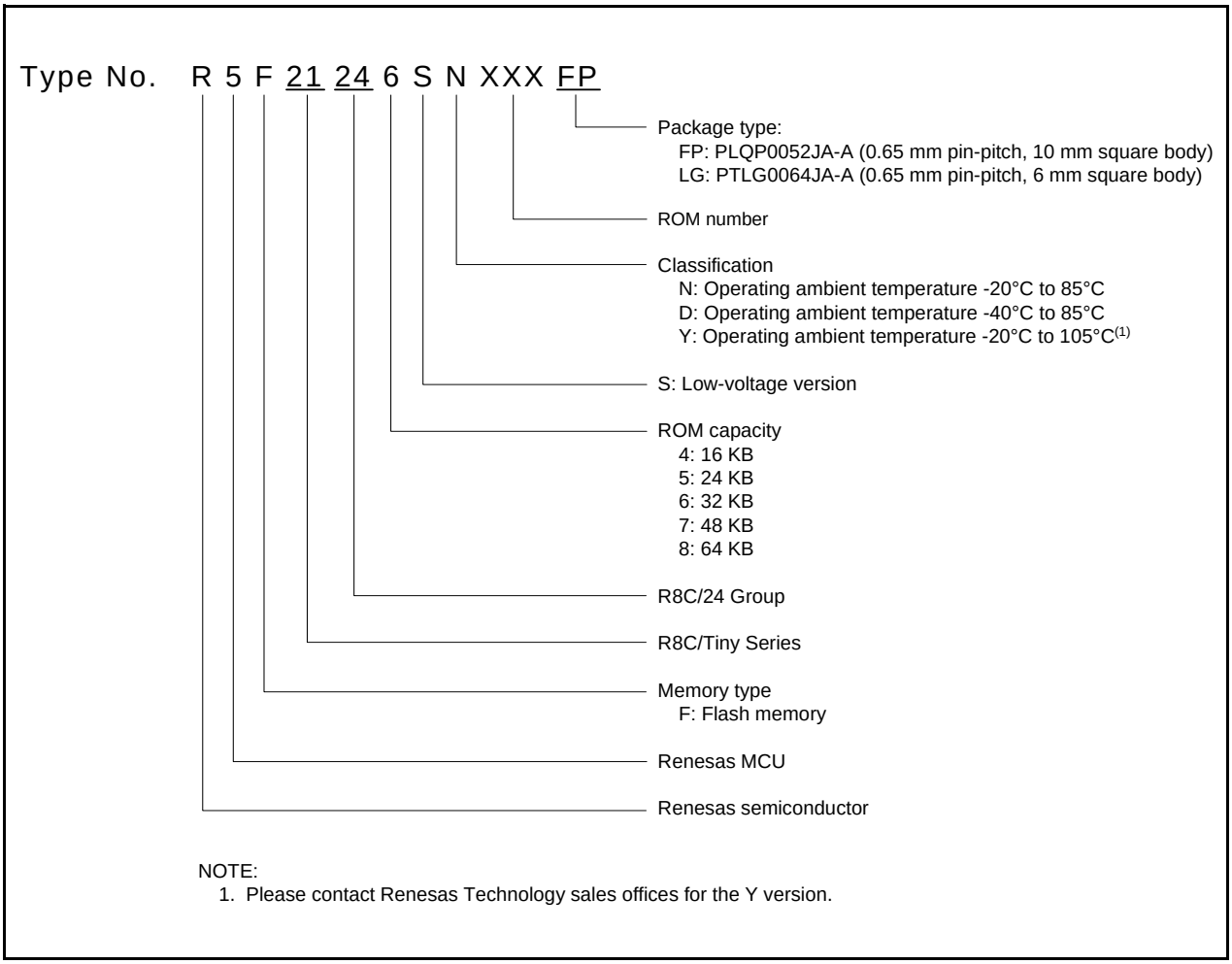
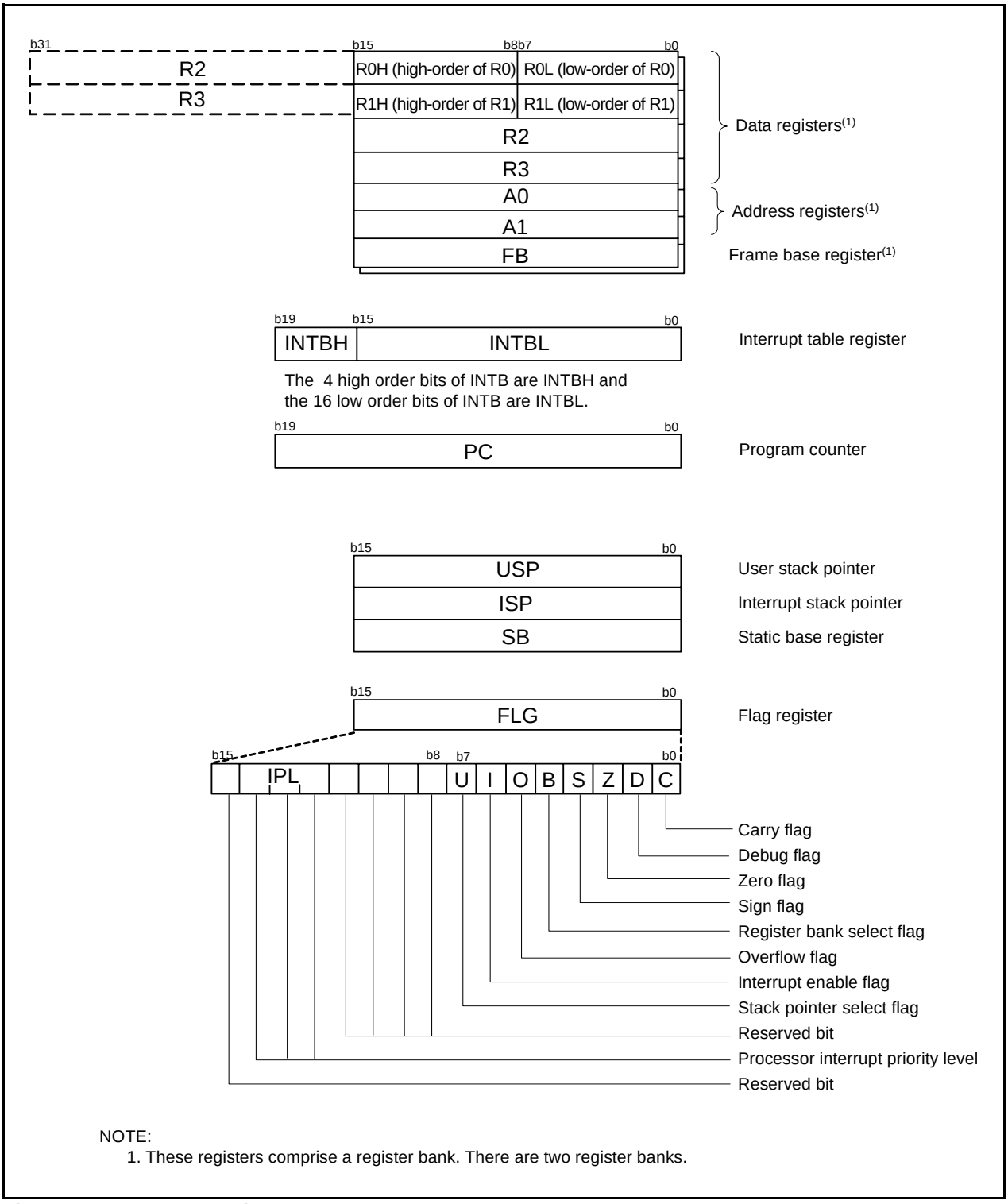


Figure 1.2 Type Number, Memory Size, and Package of R8C/24 Group

2. Central Processing Unit (CPU)

Figure 2.1 shows the CPU Registers. The CPU contains 13 registers. R0, R1, R2, R3, A0, A1, and FB configure a register bank. There are two sets of register bank.

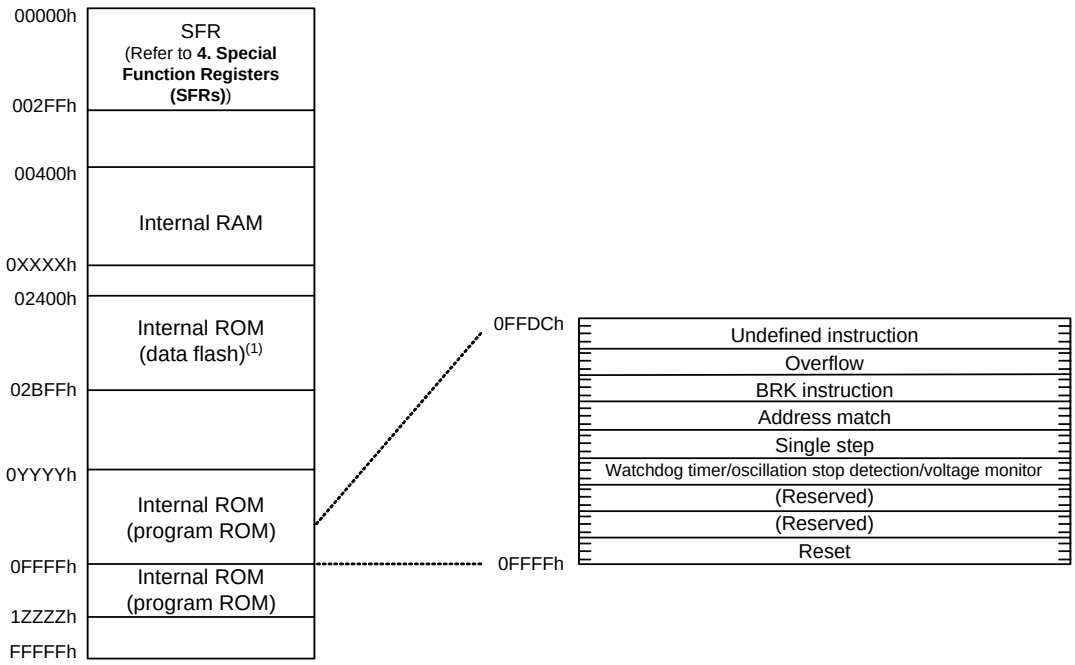


NOTE:
1. These registers comprise a register bank. There are two register banks.

Figure 2.1 CPU Registers

3.2 R8C/25 Group

Figure 3.2 is a Memory Map of R8C/25 Group. The R8C/25 group has 1 Mbyte of address space from addresses 00000h to FFFFFh.
The internal ROM (program ROM) is allocated lower addresses, beginning with address 0FFFFh. For example, a 48-Kbyte internal ROM area is allocated addresses 04000h to 0FFFFh.
The fixed interrupt vector table is allocated addresses 0FFDCh to 0FFFFh. They store the starting address of each interrupt routine.
The internal ROM (data flash) is allocated addresses 02400h to 02BFFh.
The internal RAM area is allocated higher addresses, beginning with address 00400h. For example, a 2-Kbyte internal RAM is allocated addresses 00400h to 00BFFh. The internal RAM is used not only for storing data but also for calling subroutines and as stacks when interrupt requests are acknowledged.
Special function registers (SFRs) are allocated addresses 00000h to 002FFh. The peripheral function control registers are allocated here. All addresses within the SFR, which have nothing allocated are reserved for future use and cannot be accessed by users.



NOTES:
1. Data flash block A (1 Kbyte) and B (1 Kbyte) are shown.
2. The blank regions are reserved. Do not access locations in these regions.

Part Number	Internal ROM			Internal RAM	
	Size	Address 0YYYYh	Address 1ZZZZh	Size	Address 0XXXXh
R5F21254SNFP, R5F21254SNXXXFP, R5F21254SDFP, R5F21254SDXXXFP, R5F21254SNLG, R5F21254SNXXXLG	16 Kbytes	0C000h	–	1 Kbyte	007FFh
R5F21255SNFP, R5F21255SNXXXFP, R5F21255SDFP, R5F21255SDXXXFP	24 Kbytes	0A000h	–	2 Kbytes	00BFFh
R5F21256SNFP, R5F21256SNXXXFP, R5F21256SDFP, R5F21256SDXXXFP, R5F21256SNLG, R5F21256SNXXXLG	32 Kbytes	08000h	–	2 Kbytes	00BFFh
R5F21257SNFP, R5F21257SNXXXFP, R5F21257SDFP, R5F21257SDXXXFP	48 Kbytes	04000h	–	2.5 Kbytes	00DFFh
R5F21258SNFP, R5F21258SNXXXFP, R5F21258SDFP, R5F21258SDXXXFP	64 Kbytes	04000h	13FFFh	3 Kbytes	00FFFh

Figure 3.2 Memory Map of R8C/25 Group

Table 4.7 SFR Information (7)(1)

Address	Register	Symbol	After reset
0180h			
0181h			
0182h			
0183h			
0184h			
0185h			
0186h			
0187h			
0188h			
0189h			
018Ah			
018Bh			
018Ch			
018Dh			
018Eh			
018Fh			
0190h			
0191h			
0192h			
0193h			
0194h			
0195h			
0196h			
0197h			
0198h			
0199h			
019Ah			
019Bh			
019Ch			
019Dh			
019Eh			
019Fh			
01A0h			
01A1h			
01A2h			
01A3h			
01A4h			
01A5h			
01A6h			
01A7h			
01A8h			
01A9h			
01AAh			
01ABh			
01ACh			
01ADh			
01AEh			
01AFh			
01B0h			
01B1h			
01B2h			
01B3h	Flash Memory Control Register 4	FMR4	01000000b
01B4h			
01B5h	Flash Memory Control Register 1	FMR1	1000000Xb
01B6h			
01B7h	Flash Memory Control Register 0	FMR0	00000001b
01B8h			
01B9h			
01BAh			
01BBh			
01BCh			
01BDh			
01BEh			
01BFh			

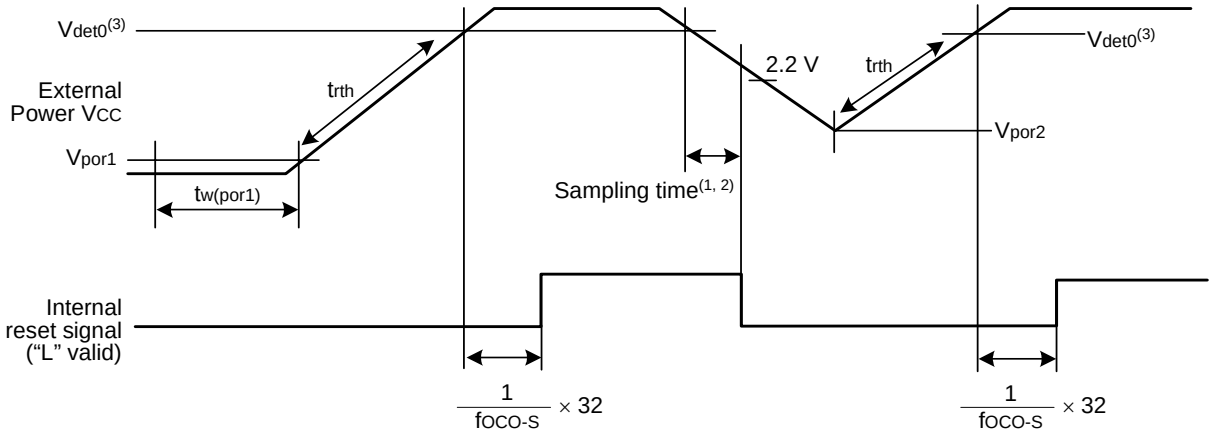
FFFFh	Option Function Select Register	OFS	(Note 2)

X: Undefined
NOTES:
1. The blank regions are reserved. Do not access locations in these regions.
2. The OFS register cannot be changed by a program. Use a flash programmer to write to it.

Table 5.9 Power-on Reset Circuit, Voltage Monitor 0 Reset Electrical Characteristics(3)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
V_{por1}	Power-on reset valid voltage(4)		–	–	0.1	V
V_{por2}	Power-on reset or voltage monitor 0 reset valid voltage		0	–	V_{det0}	V
t_{rth}	External power V_{CC} rise gradient(2)		20	–	–	mV/msec

NOTES:
1. The measurement condition is T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
2. This condition (external power V_{CC} rise gradient) does not apply if $V_{CC} \geq 1.0$ V.
3. To use the power-on reset function, enable voltage monitor 0 reset by setting the LVD0ON bit in the OFS register to 0, the VW0C0 and VW0C6 bits in the VW0C register to 1 respectively, and the VCA25 bit in the VCA2 register to 1.
4. $t_{w(por1)}$ indicates the duration the external power V_{CC} must be held below the effective voltage (V_{por1}) to enable a power on reset. When turning on the power for the first time, maintain $t_{w(por1)}$ for 30 s or more if -20°C ≤ T_{opr} ≤ 85°C, maintain $t_{w(por1)}$ for 3,000 s or more if -40°C ≤ T_{opr} < -20°C.



NOTES:
1. When using the voltage monitor 0 digital filter, ensure that the voltage is within the MCU operation voltage range (2.2 V or above) during the sampling time.
2. The sampling clock can be selected. Refer to **6. Voltage Detection Circuit** of Hardware Manual for details.
3. V_{det0} indicates the voltage detection level of the voltage detection 0 circuit. Refer to **6. Voltage Detection Circuit** of Hardware Manual for details.

Figure 5.3 Power-on Reset Circuit Electrical Characteristics

Table 5.13 Timing Requirements of Clock Synchronous Serial I/O with Chip Select(1)

Symbol	Parameter		Conditions	Standard			Unit
				Min.	Typ.	Max.	
t_{SUCYC}	SSCK clock cycle time			4	–	–	t_{CYC}(2)
t_{HI}	SSCK clock “H” width			0.4	–	0.6	t_{SUCYC}
t_{LO}	SSCK clock “L” width			0.4	–	0.6	t_{SUCYC}
t_{RISE}	SSCK clock rising time	Master		–	–	1	t_{CYC}(2)
		Slave		–	–	1	µs
t_{FALL}	SSCK clock falling time	Master		–	–	1	t_{CYC}(2)
		Slave		–	–	1	µs
t_{SU}	SSO, SSI data input setup time			100	–	–	ns
t_H	SSO, SSI data input hold time			1	–	–	t_{CYC}(2)
t_{LEAD}	$\overline{SCS}$ setup time	Slave		1t_{CYC} + 50	–	–	ns
t_{LAG}	$\overline{SCS}$ hold time	Slave		1t_{CYC} + 50	–	–	ns
t_{OD}	SSO, SSI data output delay time			–	–	1	t_{CYC}(2)
t_{SA}	SSI slave access time		2.7 V ≤ V_{CC} ≤ 5.5 V	–	–	1.5t_{CYC} + 100	ns
			2.2 V ≤ V_{CC} < 2.7 V	–	–	1.5t_{CYC} + 200	ns
t_{OR}	SSI slave out open time		2.7 V ≤ V_{CC} ≤ 5.5 V	–	–	1.5t_{CYC} + 100	ns
			2.2 V ≤ V_{CC} < 2.7 V	–	–	1.5t_{CYC} + 200	ns

NOTES:
1. V_{CC} = 2.2 to 5.5 V, V_{SS} = 0 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
2. 1t_{CYC} = 1/f1(s)

Table 5.14 Timing Requirements of I²C bus Interface(1)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
t_{SCL}	SCL input cycle time		$12t_{CYC} + 600$(2)	–	–	ns
t_{SCLH}	SCL input “H” width		$3t_{CYC} + 300$(2)	–	–	ns
t_{SCLL}	SCL input “L” width		$5t_{CYC} + 500$(2)	–	–	ns
t_{sf}	SCL, SDA input fall time		–	–	300	ns
t_{SP}	SCL, SDA input spike pulse rejection time		–	–	$1t_{CYC}$(2)	ns
t_{BUF}	SDA input bus-free time		$5t_{CYC}$(2)	–	–	ns
t_{STAH}	Start condition input hold time		$3t_{CYC}$(2)	–	–	ns
t_{STAS}	Retransmit start condition input setup time		$3t_{CYC}$(2)	–	–	ns
t_{STOP}	Stop condition input setup time		$3t_{CYC}$(2)	–	–	ns
t_{SDAS}	Data input setup time		$1t_{CYC} + 20$(2)	–	–	ns
t_{SDAH}	Data input hold time		0	–	–	ns

NOTES:
1. V_{CC} = 2.2 to 5.5 V, V_{SS} = 0 V and T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
2. $1t_{CYC} = 1/f1(s)$

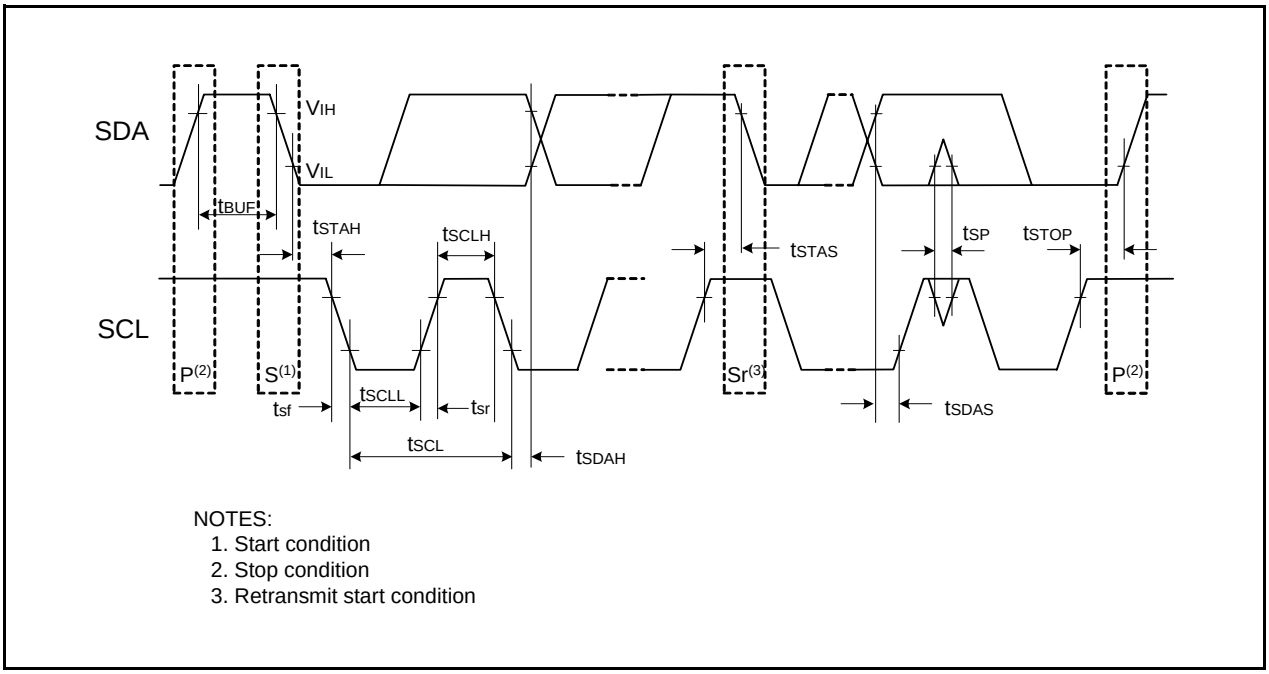


Figure 5.7 I/O Timing of I²C bus Interface

Table 5.15 Electrical Characteristics (1) [Vcc = 5 V]

Symbol	Parameter		Condition		Standard			Unit
					Min.	Typ.	Max.	
V_{OH}	Output “H” voltage	Except P2_0 to P2_7, XOUT	I_{OH} = -5 mA		V_{CC} – 2.0	–	V_{CC}	V
			I_{OH} = -200 µA		V_{CC} – 0.5	–	V_{CC}	V
		P2_0 to P2_7	Drive capacity HIGH	I_{OH} = -20 mA	V_{CC} – 2.0	–	V_{CC}	V
			Drive capacity LOW	I_{OH} = -5 mA	V_{CC} – 2.0	–	V_{CC}	V
		XOUT	Drive capacity HIGH	I_{OH} = -1 mA	V_{CC} – 2.0	–	V_{CC}	V
			Drive capacity LOW	I_{OH} = -500 µA	V_{CC} – 2.0	–	V_{CC}	V
V_{OL}	Output “L” voltage	Except P2_0 to P2_7, XOUT	I_{OL} = 5 mA		–	–	2.0	V
			I_{OL} = 200 µA		–	–	0.45	V
		P2_0 to P2_7	Drive capacity HIGH	I_{OL} = 20 mA	–	–	2.0	V
			Drive capacity LOW	I_{OL} = 5 mA	–	–	2.0	V
		XOUT	Drive capacity HIGH	I_{OL} = 1 mA	–	–	2.0	V
			Drive capacity LOW	I_{OL} = 500 µA	–	–	2.0	V
V_{T+}-V_{T-}	Hysteresis	$\overline{INT0}$, $\overline{INT1}$, $\overline{INT2}$, $\overline{INT3}$, KI0, KI1, KI2, $\overline{KI3}$, TRAIO, RXD0, RXD1, CLK0, CLK1, SSI, SCL, SDA, SSO			0.1	0.5	–	V
		$\overline{RESET}$			0.1	1.0	–	V
I_{IH}	Input “H” current		VI = 5 V, Vcc = 5V		–	–	5.0	µA
I_{IL}	Input “L” current		VI = 0 V, Vcc = 5V		–	–	-5.0	µA
R_{PULLUP}	Pull-up resistance		VI = 0 V, Vcc = 5V		30	50	167	kΩ
R_{fXIN}	Feedback resistance	XIN			–	1.0	–	MΩ
R_{fXCIN}	Feedback resistance	XCIN			–	18	–	MΩ
V_{RAM}	RAM hold voltage		During stop mode		1.8	–	–	V

NOTE:
1. V_{CC} = 4.2 to 5.5 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), f(XIN) = 20 MHz, unless otherwise specified.

Timing Requirements
(Unless Otherwise Specified: Vcc = 5 V, Vss = 0 V at Topr = 25°C) [Vcc = 5 V]

Table 5.18 XIN Input, XCIN Input

Symbol	Parameter	Standard		Unit
		Min.	Max.	
$t_{c(XIN)}$	XIN input cycle time	50	–	ns
$t_{WH(XIN)}$	XIN input “H” width	25	–	ns
$t_{WL(XIN)}$	XIN input “L” width	25	–	ns
$t_{c(XCIN)}$	XCIN input cycle time	14	–	µs
$t_{WH(XCIN)}$	XCIN input “H” width	7	–	µs
$t_{WL(XCIN)}$	XCIN input “L” width	7	–	µs

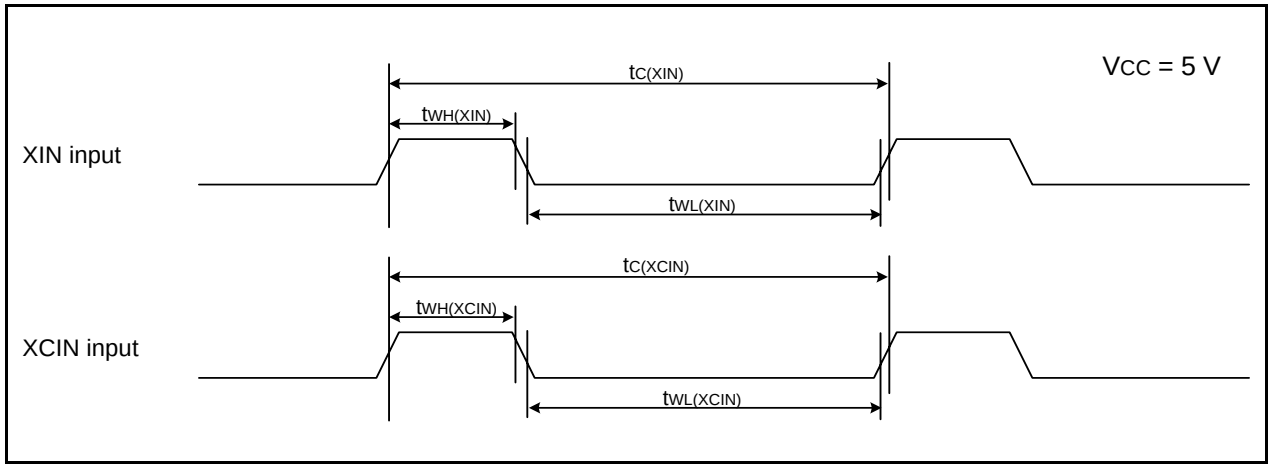


Figure 5.8 XIN Input and XCIN Input Timing Diagram when Vcc = 5 V

Table 5.19 TRAIO Input

Symbol	Parameter	Standard		Unit
		Min.	Max.	
$t_{c(TRAIO)}$	TRAIO input cycle time	100	–	ns
$t_{WH(TRAIO)}$	TRAIO input “H” width	40	–	ns
$t_{WL(TRAIO)}$	TRAIO input “L” width	40	–	ns

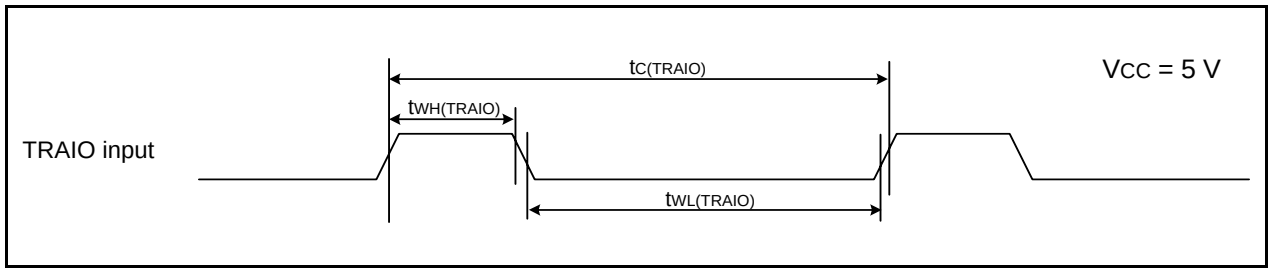


Figure 5.9 TRAIO Input Timing Diagram when Vcc = 5 V

Table 5.23 Electrical Characteristics (4) [Vcc = 3 V]
(Topr = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)

Symbol	Parameter	Condition		Standard			Unit
				Min.	Typ.	Max.	
ICC	Power supply current (VCC = 2.7 to 3.3 V) Single-chip mode, output pins are open, other pins are VSS	High-speed clock mode	XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division	–	6	–	mA
			XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8	–	2	–	mA
		High-speed on-chip oscillator mode	XIN clock off High-speed on-chip oscillator on fOCO = 10 MHz Low-speed on-chip oscillator on = 125 kHz No division	–	5	9	mA
			XIN clock off High-speed on-chip oscillator on fOCO = 10 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8	–	2	–	mA
		Low-speed on-chip oscillator mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8, FMR47 = 1	–	130	300	µA
		Low-speed clock mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz FMR47 = 1	–	130	300	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz Program operation on RAM Flash memory off, FMSTP = 1	–	30	–	µA
		Wait mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock operation VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	25	70	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock off VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	23	55	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (high drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	3.8	–	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (low drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	2.0	–	µA
		Increase during A/D converter operation	Without sample & hold	–	0.9	–	mA
			With sample & hold	–	0.5	–	mA
		Stop mode	XIN clock off, Topr = 25°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0	–	0.7	3.0	µA
			XIN clock off, Topr = 85°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0	–	1.1	–	µA

Timing requirements
(Unless Otherwise Specified: V_{CC} = 3 V, V_{SS} = 0 V at Topr = 25°C) [V_{CC} = 3 V]

Table 5.24 XIN Input, XCIN Input

Symbol	Parameter	Standard		Unit
		Min.	Max.	
$t_{c(XIN)}$	XIN input cycle time	100	–	ns
$t_{WH(XIN)}$	XIN input “H” width	40	–	ns
$t_{WL(XIN)}$	XIN input “L” width	40	–	ns
$t_{c(XCIN)}$	XCIN input cycle time	14	–	µs
$t_{WH(XCIN)}$	XCIN input “H” width	7	–	µs
$t_{WL(XCIN)}$	XCIN input “L” width	7	–	µs

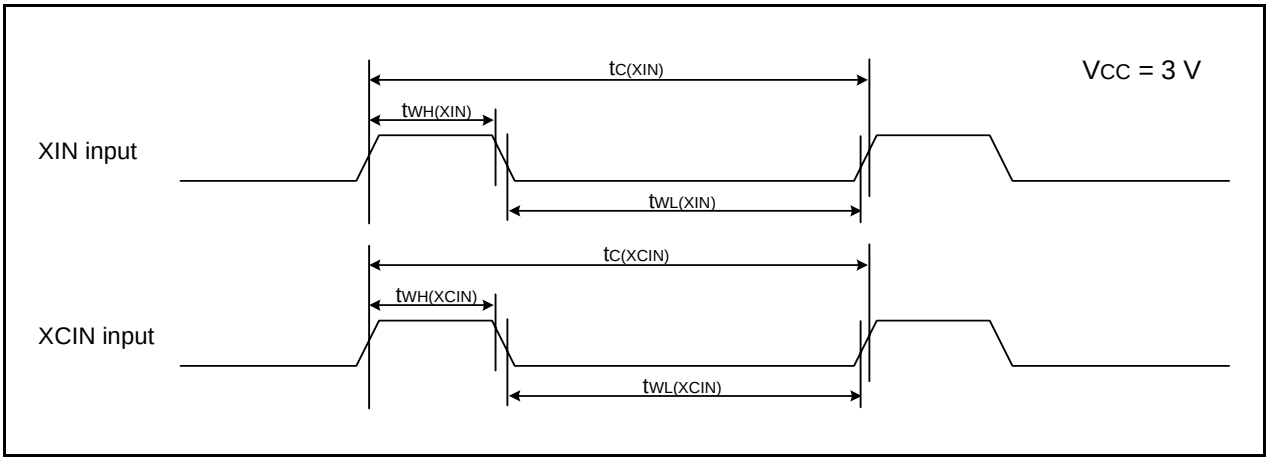


Figure 5.12 XIN Input and XCIN Input Timing Diagram when V_{CC} = 3 V

Table 5.25 TRAIO Input

Symbol	Parameter	Standard		Unit
		Min.	Max.	
$t_{c(TRAIO)}$	TRAIO input cycle time	300	–	ns
$t_{WH(TRAIO)}$	TRAIO input “H” width	120	–	ns
$t_{WL(TRAIO)}$	TRAIO input “L” width	120	–	ns

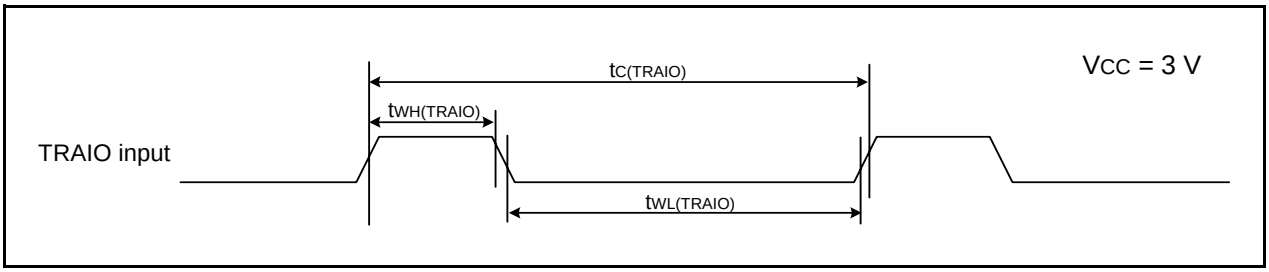


Figure 5.13 TRAIO Input Timing Diagram when V_{CC} = 3 V

Table 5.29 Electrical Characteristics (6) [Vcc = 2.2 V]
(Topr = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)

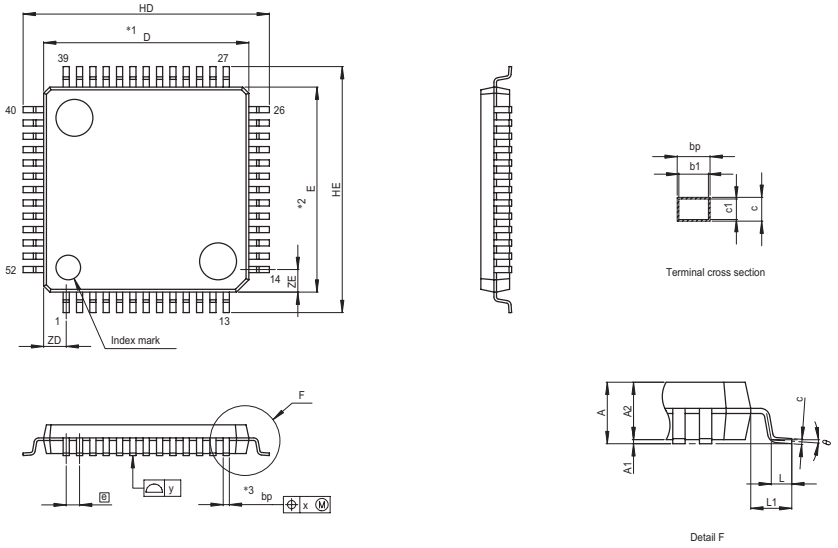
Symbol	Parameter	Condition		Standard			Unit
				Min.	Typ.	Max.	
ICC	Power supply current (VCC = 2.2 to 2.7 V) Single-chip mode, output pins are open, other pins are VSS	High-speed clock mode	XIN = 5 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division	–	3.5	–	mA
			XIN = 5 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8	–	1.5	–	mA
		High-speed on-chip oscillator mode	XIN clock off High-speed on-chip oscillator on fOCO = 5 MHz Low-speed on-chip oscillator on = 125 kHz No division	–	3.5	–	mA
			XIN clock off High-speed on-chip oscillator on fOCO = 5 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8	–	1.5	–	mA
		Low-speed on-chip oscillator mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8, FMR47 = 1	–	100	230	µA
		Low-speed clock mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz FMR47 = 1	–	100	230	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz Program operation on RAM Flash memory off, FMSTP = 1	–	25	–	µA
		Wait mode	XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock operation VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	22	60	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock off VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	20	55	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (high drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	3.0	–	µA
			XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (low drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1	–	1.8	–	µA
		Increase during A/D converter operation	Without sample & hold	–	0.4	–	mA
			With sample & hold	–	0.3	–	mA
		Stop mode	XIN clock off, Topr = 25°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0	–	0.7	3.0	µA
			XIN clock off, Topr = 85°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0	–	1.1	–	µA

Package Dimensions

Diagrams showing the latest package dimensions and mounting information are available in the “Packages” section of the Renesas Technology website.

JEITA Package Code	RENESAS Code	Previous Code	MASS[Typ.]
P-LQFP52-10x10-0.65	PLQP0052JA-A	52P6A-A	0.3g

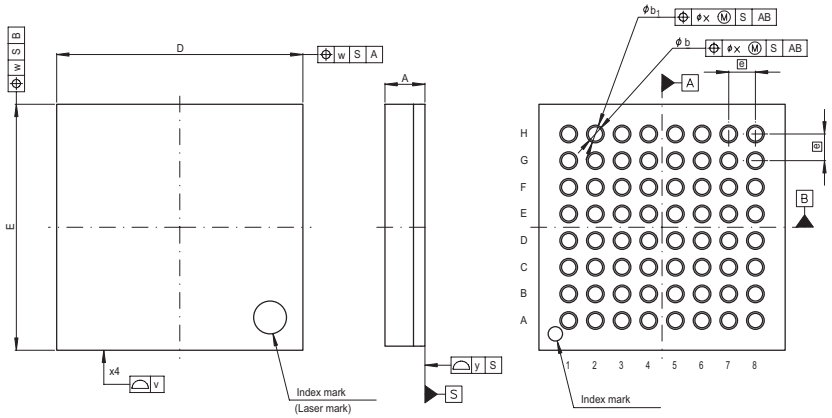
Under development



NOTE)
1. DIMENSIONS "*1" AND "*2" DO NOT INCLUDE MOLD FLASH.
2. DIMENSION "*3" DOES NOT INCLUDE TRIM OFFSET.

Reference Symbol	Dimension in Millimeters		
	Min	Nom	Max
D	9.9	10.0	10.1
E	9.9	10.0	10.1
A_2	—	1.4	—
H_D	11.8	12.0	12.2
H_E	11.8	12.0	12.2
A	—	—	1.7
A_1	0.05	0.1	0.15
b_p	0.27	0.32	0.37
b_1	—	0.30	—
c	0.09	0.145	0.20
c_1	—	0.125	—
θ	0°	—	8°
e	—	0.65	—
x	—	—	0.13
y	—	—	0.10
Z_D	—	1.1	—
Z_E	—	1.1	—
L	0.35	0.5	0.65
L_1	—	1.0	—

JEITA Package Code	RENESAS Code	Previous Code	MASS[Typ.]
P-TFLGA64-6x6-0.65	PTLG0064JA-A	64F0G	0.07g



Reference Symbol	Dimension in Millimeters		
	Min	Nom	Max
D	—	6.0	—
E	—	6.0	—
v	—	—	0.15
w	—	—	0.20
A	—	—	1.05
e	—	0.65	—
b	0.31	0.35	0.39
b_1	0.39	0.43	0.47
x	—	—	0.08
y	—	—	0.10

REVISION HISTORY	R8C/24 Group, R8C/25 Group Datasheet

Rev.	Date	Description	
		Page	Summary
0.01	Sep 17, 2004	-	First Edition issued
0.02	Dec 10, 2004	All pages	Part Number revised. R8C/26 → R8C/24, R8C/27 → R8C/25
		2, 3	Table 1.1 R8C/24 Group Performance, Table 1.2 R8C/25 Group Performance - Serial Interface: I^2C Bus Interface and Chip-select clock synchronous (SSU) added. - LIN Module added. - Interrupt: Internal factors revised; 10 → 11 - Note on Operating Ambient Temperature added.
		4	Figure 1.1 Block Diagram - LIN Module added. - Chip-select clock synchronous (SSU) is added to I^2C Bus Interface.
		5, 6	Table 1.3 Product Information of R8C/24 Group, Table 1.4 Product Information of R8C/25 Group Date and Development state revised.
		7	Figure 1.4 Pin Assignment P3_5/SCL → P3_5/SCL/SSCK, P3_3 → P3_3/SSI, P3_4/SDA → P3_4/SDA/SCS, P3_7 → P3_7/SSO, VSS/AVSS → VSS, XIN/P4_6 → P4_6/XIN, VCC/AVSS → VCC 12pin P1_7/TRAIO/INT1 to 22pin P1_0/KI0/AN8 → 20pin P1_7/TRAIO/INT1 to 30pin P1_0/KI0/AN8
		8	Table 1.5 Pin Description - Analog Power Supply Input eliminated. - SSU added.
		9	Table 1.6 Pin Name Information by Pin Number added.
		15	Table 4.1 SFR Information (1) - 0031h: Voltage Detection Register 1 → Voltage Detection A Register 1 - 0032h: Voltage Detection Register 1 → Voltage Detection A Register 2 01000001b → 00100001b (Note 4) - 0036h: "(3), 01000001b (4)" eliminated. - 0038h: Voltage Monitor 0 Control Register (2), VW0C, 00001000b (3), 01000001b (4) added.
		16	Table 4.2 SFR Information (2) - 0048h: Timer RD0 Interrupt Control Register, RD0IC, XXXXX000b added. - 0049h: Timer RD Interrupt Control Register, RDIC → Timer RD1 Interrupt Control Register, RD1IC - 004Fh: IIC Interrupt Control Register, IIC → IIC/SSU Interrupt Control Register, IIC2IC
		19	Table 4.5 SFR Information (3) - 0106h: LIN Control Register, LINCR, 00h added. -0107h: LIN Status Register, LINST, 00h added.

Rev.	Date	Description	
		Page	Summary
0.30	Sep 01, 2005	7	Figure 1.4 Pin Assignment • Pin name revised; VSS → VSS/AVSS, VCC → VCC/AVCC, P1_5/RXD0/(TRAIO)/($\overline{\text{INT1}}$) → P1_5/RXD0/(TRAIO)/($\overline{\text{INT1}}$)(2), P6_6/$\overline{\text{INT2}}$/(TXD1) → P6_6/$\overline{\text{INT2}}$/TXD1, P6_7/$\overline{\text{INT3}}$/(RXD1) → P6_7/$\overline{\text{INT3}}$/RXD1, P6_5 → P6_5/CLK1 • NOTE2 added
		8	Table 1.5 Pin Description • Analog Power Supply Input: line added • $\overline{\text{INT}}$ Interrupt Input: "$\overline{\text{INT0}}$ Timer RD input pins. $\overline{\text{INT1}}$ Timer RA input pins." added • Serial Interface: "CLK1" added • "I2C Bus Interface (IIC)" → "I2C Bus Interface" • "SSU" → "Clock Synchronous Serial I/O with Chip Select"
		9	Table 1.6 Pin Name Information by Pin Number revised • Pin Number 10: "VSS" → "VSS/AVSS" • Pin Number 12: "$\overline{\text{VCC}}$" → "VCC/AVCC" • Pin Number 27: "$\overline{\text{INT0}}$" added • Pin Number 28: "(TXD1)" → "TXD1" • Pin Number 29: "(RXD1)" → "RXD1" • Pin Number 35: "CLK1" added
		15	Tabel 4.1 SFR Information(1) revised: • 0012h: X0h → 00h • 0013h: XXXXXX00b → 00h • 0016h: X0h → 00h • 0036h: Voltage Monitor 1 Control Register(2) → Voltage Monitor 1 Control Register(5) • 0038h: 00001000b(3), 01000001b(4) → 0000X000b(3), 0100X001b(4) • NOTES2, 5: "the voltage monitor 1 reset" added • NOTE3: "voltage monitor 1 reset" → "voltage monitor 0 reset"
		16	Tabel 4.2 SFR Information(2) revised: • 0048h: RD0IC → TRD0IC • 0049h: RD1IC → TRD1IC • 004Ah: REIC → TREIC • 004Fh: SSU/IIC Interrupt Control Register, IIC2AIC → SSU/IIC Interrupt Control Register(2), SSUAIC/IIC2AIC • 0056h: RAIC → TRAIC • 0058h: RBIC → TRBIC • NOTE2 added
		17	Tabel 4.3 SFR Information(3) revised: • 00BCh: 00h → 00h/0000X000b
		18	Tabel 4.4 SFR Information(4) revised: • 00D6h: 00000XXXb → 00h • 00F5h: UART1 Function Select Register, U1SR, XXh added

Rev.	Date	Description	
		Page	Summary
0.30	Sep 01, 2005	19	Tabel 4.5 SFR Information(5) revised: • 0118h : Timer RE Second Data Register/Counter Register → Timer RE Second Data Register/Counter Data Register
		20	Tabel 4.6 SFR Information(6) revised: • 0145h POCR0 → TRDPOCR0 • 0146h, 0147h TRDCNT0 → TRD0 • 0148h, 0149h GRA0 → TRDGRA0 • 014Ah, 014Bh GRB0 → TRDGRB0 • 014Ch, 014Dh GRC0 → TRDGRC0 • 014Eh, 014Fh GRD0 → TRDGRD0 • 0155h POCR1 → TRDPOCR1 • 0156h, 0157h TRDCNT1 → TRD1 • 0158h, 0159h GRA1 → TRDGRA1 • 015Ah, 015Bh GRB1 → TRDGRB1 • 015Ch, 015Dh GRC1 → TRDGRC1 • 015Eh, 015Fh GRD1 → TRDGRD1
		21	Tabel 4.7 SFR Information(7) revised: • 01B5h: 01000101b → 1000000Xb • 01B7h: XX000001b → 00000001b • FFFFh: (Note 2) added
		22 to 44	5. Electrical Characteristics added
0.40	Jan 24, 2006	all pages	• “Preliminary” deleted • Symbol name “TRDMDR” → “TRDMR”, “SSUAIC” → “SSUIC”, and “IIC2AIC” → “IICIC” revised • Pin name “TCLK” → “TRDCLK” revised
		2	Table 1.1 Functions and Specifications for R8C/24 Group revised
		3	Table 1.2 Functions and Specifications for R8C/25 Group revised
		4	Figure 1.1 Block Diagram; “Peripheral Functions” added, “System Clock Generation” → “System Clock Generator” revised
		5	Table 1.3 Product Information for R8C/24 Group revised
		6	Table 1.4 Product Information for R8C/25 Group revised
		7	Figure 1.4 Pin Assignments (Top View) “TCLK” → “TRDCLK” revised
		8	Table 1.5 Pin Functions “TCLK” → “TRDCLK” revised
		9	Table 1.6 Pin Name Information by Pin Number; “TCLK” → “TRDCLK” revised
		10	Figure 2.1 CPU Registers; “Reserved Area” → “Reserved Bit” revised
		12	2.8.10 Reserved Area; “Reserved Area” → “Reserved bit” revised
		13	Figure 3.1 Memory Map of R8C/24 Group; “Program area” → “program ROM” revised
		14	3.2 R8C/25 Group, Figure 3.2 Memory Map of R8C/25 Group; “Data area” → “data flash”, “Program area” → “program ROM” revised

Rev.	Date	Description	
		Page	Summary
0.40	Jan 24, 2006	15	Table 4.1 SFR Information(1); 0024h: "TBD" → "When shipping" NOTES 3 and 4 revised
		19	Table 4.5 SFR Information (5); 0118h: "Timer RE Second Data Register" → "Timer RE Second Data Register / Counter Data Register" 0119h: "Timer RE Minute Data Register" → "Timer RE Minute Data Register / Compare Data Register" 0138h: "TRDMDR" → "TRDMR" 013Bh: "Timer RD Output Master Enable Register" → "Timer RD Output Master Enable Register 1"
		22	Table 5.1 Absolute Maximum Ratings; "VCC" → "VCC/AVCC" revised Table 5.2 Recommended Operating Conditions revised
		23	Table 5.3 A/D Converter Characteristics revised
		24	Table 5.4 Flash Memory (Program ROM) Electrical Characteristics revised
		25	Table 5.5 Flash Memory (Data flash Block A, Block B) Electrical revised
		26	Table 5.6 Voltage Detection 0 Circuit Electrical Characteristics revised Table 5.7 Voltage Detection 1 Circuit Electrical Characteristics revised Table 5.8 Voltage Detection 2 Circuit Electrical Characteristics revised
		28	Table 5.11 High-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.12 Low-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.13 Power Supply Circuit Timing Characteristics revised
		29	Table 5.14 Timing Requirements of Clock Synchronous Serial I/O with Chip Select revised
		33	Table 5.15 Timing Requirements of I^2C bus Interface NOTE1 revised
		34	Table 5.16 Electrical Characteristics (1) [VCC = 5 V] revised
		35	Table 5.17 Electrical Characteristics (2) [VCC = 5 V] revised
		36	Table 5.18 XIN Input, XCIN Input revised
		37	Table 5.20 Serial Interface revised
		38	Table 5.22 Electrical Characteristics (3) [VCC = 3 V] revised
		39	Table 5.23 Electrical Characteristics (4) [Vcc = 3 V] revised
		40	Table 5.24 XIN Input, XCIN Input revised
		41	Table 5.26 Serial Interface revised
		42	Table 5.28 Electrical Characteristics (5) [VCC = 2.2 V] revised
		43	Table 5.29 Electrical Characteristics (6) [Vcc = 2.2 V] revised
		44	Table 5.30 XIN Input, XCIN Input revised Table 5.31 TRAIO Input, $\overline{INT1}$ Input revised
		45	Table 5.32 Serial Interface revised Table 5.33 External Interrupt $\overline{INTi}$ (i = 0, 2, 3) Input

REVISION HISTORY	R8C/24 Group, R8C/25 Group Datasheet

Rev.	Date	Description	
		Page	Summary
0.40	Jan 24, 2006	46	Package Dimensions; "TBD" → "PLQP0052JA-A (52P6A-A)" added
1.00	May 31, 2006	all pages	"Under development" deleted
		1	1. Overview; "data flash ROM" → "data flash" revised
		3	Table 1.2 Functions and Specifications for R8C/25 Group revised
		4	Figure 1.1 Block Diagram; "System clock generator" → "System clock generation circuit" revised
		5 to 6	Table 1.3 Product Information for R8C/24 Group and Table 1.4 Product Information for R8C/25 Group; A part of (D) mark is deleted.
		9	Table 1.6 Pin Name Information by Pin Number NOTE1 added
		15	Table 4.1 SFR Information(1); 001Ch: "00h" → "00h, 10000000b" revised 0029h: High-Speed On-Chip Oscillator Control Register 4 FRA4 When shipping added 002Bh: High-Speed On-Chip Oscillator Control Register 6 FRA6 When shipping added NOTE6 added
		19	Table 4.5 SFR Information(5); 0118h: Timer RE Second Data Register / Counter Data Register, 0119h: Timer RE Minute Data Register / Compare Data Register register name revised
		20	Table 4.6 SFR Information(6); 0143h: "11000000b" → "11100000b" revised
		22	Table 5.2 Recommended Operating Conditions revised
		24	Table 5.4 Flash Memory (Program ROM) Electrical Characteristics revised
		25	Table 5.5 Flash Memory (Data flash Block A, Block B) Electrical Characteristics revised
		26	Figure 5.2 Time delay until Suspend title revised
		27	Table 5.9 Voltage Monitor 0 Reset Electrical Characteristics → Table 5.9 Power-on Reset Circuit, Voltage Monitor 0 Reset Electrical Characteristics revised Table 5.10 Power-on Reset Circuit Electrical Characteristics (When Not Using Voltage Monitor 0 Reset) deleted Figure 5.3 Power-on Reset Circuit Electrical Characteristics revised
		28	Table 5.10 High-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.11 Low-speed On-Chip Oscillator Circuit Electrical Characteristics revised
		35	Table 5.16 Electrical Characteristics (2) [Vcc = 5 V] revised
		39	Table 5.22 Electrical Characteristics (4) [Vcc = 3 V] revised
		43	Table 5.28 Electrical Characteristics (6) [Vcc = 2.2 V] revised
		46	Package Dimensions; "The latest package ... Renesas Technology website." added